Alcon LenSx, Inc.

LenSx Laser System

Report No. LENS0005

Report Prepared By



www.nwemc.com 1-888-EMI-CERT

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22975 NW Evergreen Parkway Suite 400 Hillsboro, Oregon 97124

Certificate of Test

Last Date of Test: December 17, 2010 Alcon LenSx, Inc. Model: LenSx Laser System

Emissions						
Test Description	Specification	Test Method	Pass/Fail			
Field Strength of Fundamental	FCC 15.225:2010	ANSI C63.10:2009	Pass			
Field Strength of Spurious Emissions	FCC 15.225:2010	ANSI C63.10:2009	Pass			
Frequency Stability	FCC 15.225:2010	ANSI C63.10:2009	Pass			
Occupied Bandwidth	FCC 15.225:2010	ANSI C63.10:2009	Pass			
AC Powerline Conducted Emissions	FCC 15.207:2010	ANSI C63.10:2009	Pass			

Modifications made to the product

See the Modifications section of this report

Test Facility

The measurement facility used to collect the data is located at:

Northwest EMC, Inc. 41 Tesla Ave. Irvine, CA 92618

Phone: (503) 844-4066 Fax: 844-3826

This site has been fully described in a report filed with and accepted by the FCC (Federal Communications Commission) and Industry Canada (Site filing #2834B-1).

Approved By:

Tim O'Shea, Operations Manager

NVLAP

NVLAP Lab Code: 200676-0

This report must not be used to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the federal government of the United States of America.

Product compliance is the responsibility of the client, therefore the tests and equipment modes of operation represented in this report were agreed upon by the client, prior to testing. This Report may only be duplicated in its entirety. The results of this test pertain only to the sample(s) tested. The specific description is noted in each of the individual sections of the test report supporting this certificate of test.



Revision History

Revision 06/29/09

Revision Number	Description	Date	Page Number
00	None		



Accreditations and Authorizations

FCC

Accredited by NVLAP for performance of FCC radio, digital, and ISM device testing. Our Open Area Test Sites, certification chambers, and conducted measurement facilities have been fully described in reports filed with the FCC and accepted by the FCC in letters maintained in our files. Northwest EMC has been accredited by ANSI to ISO / IEC Guide 65 as a product certifier. We have been designated by the FCC as a Telecommunications Certification Body (TCB). This allows Northwest EMC to certify transmitters to FCC specifications in accordance with 47 CFR 2.960 and 2.962.

NVLAP

Northwest EMC, Inc. is accredited under the National Voluntary Laboratory Accreditation Program (NVLAP) for satisfactory compliance with the requirements of ISO/IEC 17025 for Testing Laboratories. NVLAP is administered by the National Institute of Standards and Technology (NIST), an agency of the U.S. Commerce Department. The NVLAP accreditation encompasses Electromagnetic Compatibility Testing in accordance with the European Union EMC Directive 2004/108/EC, and ANSI C63.4. Additionally, Northwest EMC is accredited by NVLAP to perform radio testing in accordance with the European Union R&TTE Directive 1999/5/EEC, the requirements of FCC, and the RSS radio standards for Industry Canada.

Industry Canada

Accredited by NVLAP for performance of Industry Canada RSS and ICES testing. Our Open Area Test Sites and certification chambers comply with RSS-Gen, Issue 2 and have been filed with Industry Canada and accepted. Northwest EMC has been accredited by ANSI to ISO / IEC Guide 65 as a product certifier. We have been designated by NIST and recognized by Industry Canada as a Certification Body (CB) per the APEC Mutual Recognition Arrangement (MRA). This allows Northwest EMC to certify transmitters to Industry Canada technical requirements. (Site Filing Numbers - Hillsboro: 2834D-1, 2834D-2, Sultan: 2834C-1, Irvine: 2834B-1, 2834B-2, Brooklyn Park: 2834E-1)

CAB

Designated by NIST and validated by the European Commission as a Conformity Assessment Body (CAB) to conduct tests and approve products to the EMC directive and transmitters to the R&TTE directive, as described in the U.S. - EU Mutual Recognition Agreement.

Australia/New Zealand

The National Association of Testing Authorities (NATA), Australia has been appointed by the ACA as an accreditation body to accredit test laboratories and competent bodies for EMC standards. Accredited test reports or assessments by competent bodies must carry the NATA logo. Test reports made by an overseas laboratory that has been accredited for the relevant standards by an overseas accreditation body that has a Mutual Recognition Agreement (MRA) with NATA are also accepted as technical grounds for product conformity. The report should be endorsed with the respective logo of the accreditation body (NVLAP).



Accreditations and Authorizations

VCCI

Accepted as an Associate Member to the VCCI, Acceptance No. 564. Conducted and radiated measurement facilities have been registered in accordance with Regulations for Voluntary Control Measures, Article 8. (Registration Numbers. - Hillsboro: C-1071, R-1025, G-84, C-2687, T-1658, and R-2318, Irvine: R-1943, G-85, C-2766, and T-1659, Sultan: R-871, G-83, C-1784, and T-1511, Brooklyn Park: R-3125, G-86, G-141, C-3464, and T-1634).

BSMI

Northwest EMC has been designated by NIST and validated by C-Taipei (BSMI) as a CAB to conduct tests as described in the APEC Mutual Recognition Agreement (US0017).

GOST

Northwest EMC, Inc. has been assessed and accredited by the Russian Certification bodies Certinform VNIINMASH, CERTINFO, SAMTES, and Federal CHEC, to perform EMC and Hygienic testing for Information Technology Products. As a result of their laboratory assessment, they will accept test results from Northwest EMC, Inc. for product certification

KCC

Northwest EMC, Inc is a CAB designated by MRA partners and recognized by Korea. (Assigned Lab Numbers: Hillsboro: US0017, Irvine: US0158, Sultan: US0157, Brooklyn Park: US0175)

VIETNAM

Vietnam MIC has approved Northwest EMC as an accredited test lab. Per Decision No. 194/QD-QLCL (dated December 15, 2009), Northwest EMC test reports can be used for Vietnam approval submissions.

SCOPE

For details on the Scopes of our Accreditations, please visit: http://www.nwemc.com/accreditations/



Northwest EMC Locations

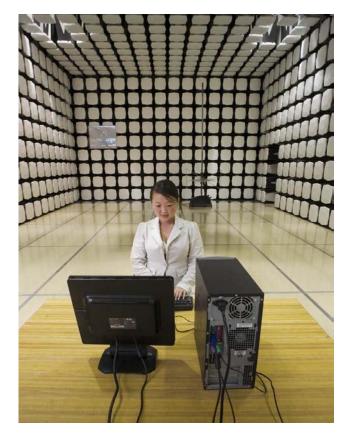




Oregon Labs EV01-EV12 22975 NW Evergreen Pkwy Suite 400 Hillsboro, OR 97124 (503) 844-4066 California Labs OC01-OC13 41 Tesla Irvine, CA 92618 (949) 861-8918 Minnesota Labs MN01-MN08 9349 W Broadway Ave. Brooklyn Park, MN 55445 (763) 425-2281 Washington Labs SU01-SU07 14128 339th Ave. SE Sultan, WA 98294 (360) 793-8675 New York Labs WA01-WA04 4939 Jordan Rd. Elbridge, NY 13060 (315) 685-0796







Rev 11/17/06

Party Requesting the Test

Company Name:	Alcon LenSx, Inc.
Address:	33 Journey
City, State, Zip:	Aliso Viejo, CA 92656
Test Requested By:	Scott DeLong
Model:	LenSx Laser System
First Date of Test:	December 13, 2010
Last Date of Test:	December 17, 2010
Receipt Date of Samples:	December 13, 2010
Equipment Design Stage:	Production
Equipment Condition:	No Damage

Information Provided by the Party Requesting the Test

Functional Description of the EUT (Equipment Under Test):

13.56 MHz RFID. This is a low Power Part 15 transmitter. Less than 0dBm output power

Testing Objective:

RFID radio seeking system approval under FCC 15.225



Configurations

CONFIGURATION 1 LENS0005

Software/Firmware Running during test			
Description	Version		
LenSx Laser System Application	2.1		
Skyetek	01010679		

EUT			
Description	Manufacturer	Model/Part Number	Serial Number
LenSx Laser System	Alcon LenSx, Inc.	LenSx Laser System	0510-X007
RFID Device	Skyetek	M2-MH	PN# SM-M2-HF-LF

Cables							
Cable Type	Shield	Length (m)	Ferrite	Connection 1	Connection 2		
AC Cable	Yes	3.0m	No	LenSx Laser System	AC Mains		
PA = Cable	PA = Cable is permanently attached to the device. Shielding and/or presence of ferrite may be unknown.						

Revision 4/28/03

	Equipment modifications							
Item	Date	Test	Modification	Note	Disposition of EUT			
1	12/13/2010	AC Powerline Conducted Emissions	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.			
2	12/13/2010	Field Strength of Spurious Emissions	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.			
3	12/13/2010	Frequency Stability	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.			
4	12/16/2010	Field Strength of Fundamental	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.			
5	12/17/2010	Occupied Bandwidth	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	Scheduled testing was completed.			

FIELD STRENGTH OF FUNDAMENTAL

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

MODES OF OPERATION

RFID ON.

POWER SETTINGS INVESTIGATED

120VAC/60Hz

FREQUENCY RANGE INVESTIGATED					
Start Frequency	13.56 MHz	Stop Frequency	13.56 MHz		

SAMPLE CALCULATIONS

Radiated Emissions: Field Strength = Measured Level + Antenna Factor + Cable Factor - Amplifier Gain + Distance Adjustment Factor + External Attenuation

TEST EQUIPMENT					
Description	Manufacturer	Model	ID	Last Cal.	Interval
OC10 Cables	N/A	10kHz-1GHz RE Cables	OCH	4/1/2010	13
Spectrum Analyzer	Agilent	E4446A	AAY	1/15/2010	12
Antenna, Loop	EMCO	6502	AZB	12/6/2010	24

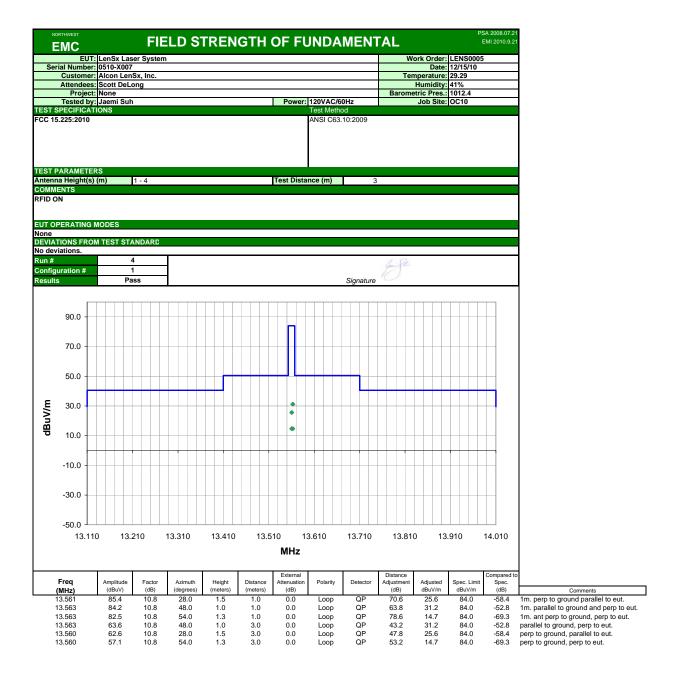
Frequency Range	Peak Data	Quasi-Peak Data	Average Data			
(MHz)	(kHz)	(kHz)	(kHz)			
0.01 - 0.15	1.0	0.2	0.2			
0.15 - 30.0	10.0	9.0	9.0			
30.0 - 1000	100.0	120.0	120.0			
Above 1000	1000.0	N/A	1000.0			

MEASUREMENT UNCERTAINTY

A measurement uncertainty estimation has been performed for each test per our internal quality document WP 342. The estimation is used to compare the measured result with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. The measurement uncertainty estimation is available upon request.

TEST DESCRIPTION

The antennas to be used with the EUT were tested. The EUT was transmitting and receiving while set at the lowest channel, a middle channel, and the highest channel available. While scanning, emissions from the EUT were maximized by rotating the EUT, adjusting the measurement antenna height and polarization, and manipulating the EUT antenna in 3 orthogonal planes (per ANSI C63.10:2009).



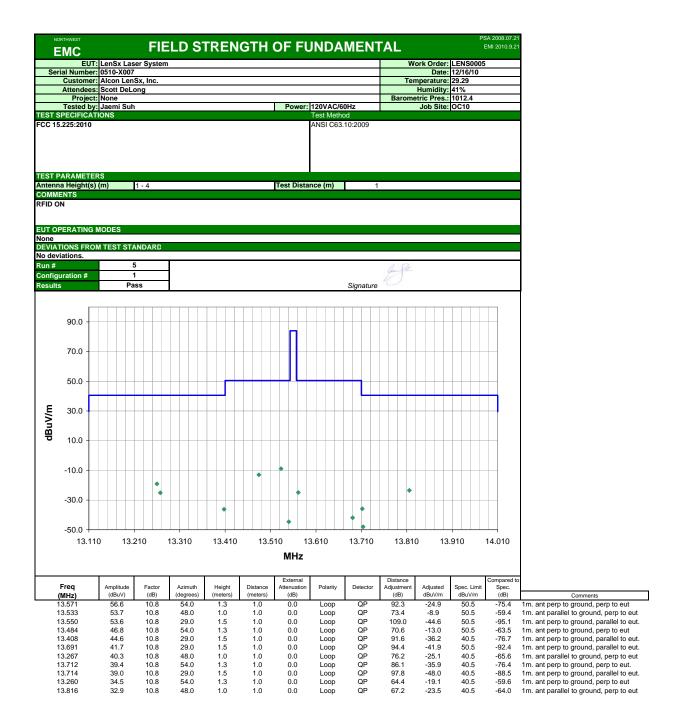
Distance Adjustment Factor for Fundamental Emissions below 30 MHz

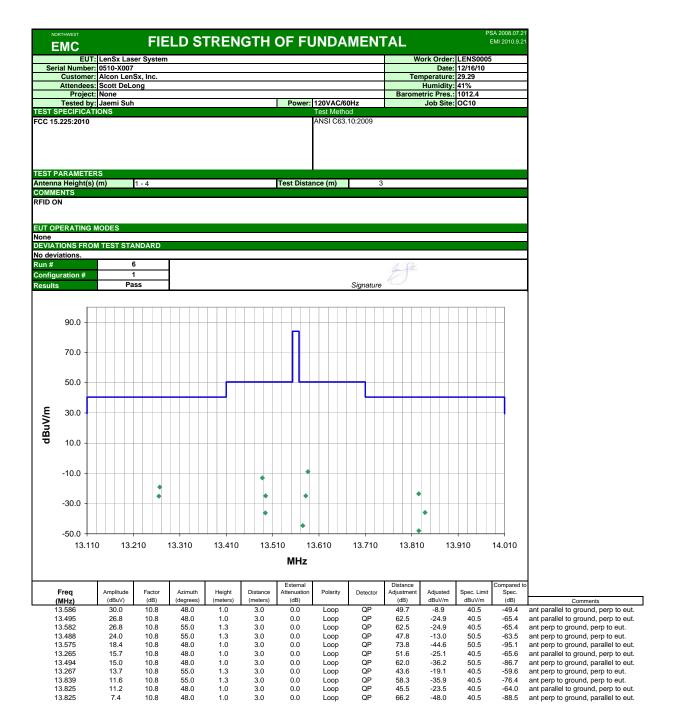
Method: Per 47 CFR 15.31(f)(2), the data was extrapolated based upon a the measured fall-off (at each frequency / polarity).

EUT: LenSx Laser System

S/N: 0510-X007 **Date:** 12/15/10 **Job Number:** LENS0005

Frequency (MHz)	Loop Antenna Polarity	Test Distance (meters)	Adjusted Level	Fall-Off from 1 to 3 m	Extrapolation Factor for Specification Limit (dB / decade)	Test Distance of Spec. Limit (meters)	Distance Adjustment Factor (dB)
13.561	Perp/Gnd, Par/EUT	1	96.2	22.8	47.8	30.0	70.6
13.561	Perp/Gnd, Par/EUT	3	73.4	22.0	47.0	30.0	47.8
13.563	Par/Gnd, Perp/EUT	1	95.0	20.6	43.2	30.0	63.8
13.563	Par/Gnd, Perp/EUT	3	74.4	20.0	43.2	30.0	43.2
13.563	Perp/Gnd, Perp/EUT	1	93.3	25.4	53.2	30.0	78.6
13.563	Perp/Gnd, Perp/EUT	3	67.9	20.4	53.2	30.0	53.2





Distance Adjustment Factor for Spurious Emissions below 30 MHz

Method: Per 47 CFR 15.31(f)(2), the data was extrapolated based upon a the measured fall-off (at each frequency / polarity).

EUT: LenSx Laser System

S/N: 0510-X007 **Date:** 12/15/10 **Job Number:** LENS0005

Frequency	Loop Antenna Polarity	Test Distance	Adjusted Level	Fall-Off from 1 to 3 m	Extrapolation Factor for Specification Limit	Test Distance of Spec. Limit	Distance Adjustment Factor
(MHz)		(meters)	(dBuV/m)	(dB)	(dB / decade)	(meters)	(dB)
13.571	Perp/Gnd, Perp/EUT	1	67.4	29.8	62.5	30.0	92.3
13.571	Perp/Gnd, Perp/EUT	3	37.6				62.5
13.533	Par/Gnd, Perp/EUT	1	64.5	23.7	49.7	30.0	73.4
13.533	Par/Gnd, Perp/EUT	3	40.8				49.7
13.550	Perp/Gnd, Par/EUT	1	64.4	35.2	73.8	30.0	109.0
13.550	Perp/Gnd, Par/EUT	3	29.2			- 55.0	73.8
13.484	Perp/Gnd, Perp/EUT	1	57.6	22.8	47.8	30.0	70.6
13.484	Perp/Gnd, Perp/EUT	3	34.8	-	-		47.8
13.408	Perp/Gnd, Par/EUT	1	55.4	29.6	62.0	30.0	91.6
13.408	Perp/Gnd, Par/EUT	3	25.8				62.0
13.691	Perp/Gnd, Par/EUT	1	52.5	30.5	63.9	30.0	94.4
13.691	Perp/Gnd, Par/EUT	3	22.0				63.9
13.267	Par/Gnd, Perp/EUT	1	51.1	24.6	51.6	30.0	76.2
13.267	Par/Gnd, Perp/EUT	3	26.5				51.6
13.712	Perp/Gnd, Perp/EUT	1	50.2	27.8	58.3	30.0	86.1
13.712	Perp/Gnd, Perp/EUT	3	22.4				58.3
13.714	Perp/Gnd, Par/EUT	1	49.8	31.6	66.2	30.0	97.8
13.714	Perp/Gnd, Par/EUT	3	18.2				66.2
13.260	Perp/Gnd, Perp/EUT	1	45.3	20.8	43.6	30.0	64.4
13.260	Perp/Gnd, Perp/EUT	3	24.5				43.6
13.816	Par/Gnd, Perp/EUT	1	43.7	21.7	45.5	30.0	67.2
13.816	Par/Gnd, Perp/EUT	3	22.0				45.5

FIELD STRENGTH OF SPURIOUS EMISSIONS

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

MODES OF OPERATION

RFID On.

POWER SETTINGS INVESTIGATED

120VAC/60Hz

FREQUENCY RANGE INVESTIGATED					
Start Frequency	150 KHz	Stop Frequency	1000 MHz		

SAMPLE CALCULATIONS

Radiated Emissions: Field Strength = Measured Level + Antenna Factor + Cable Factor - Amplifier Gain + Distance Adjustment Factor + External Attenuation

TEST EQUIPMENT					
Description	Manufacturer	Model	ID	Last Cal.	Interval
Antenna, Loop	EMCO	6502	AZB	12/6/2010	24
Antenna, Biconilog	Antenna, Biconilog EMCO		AXJ	2/24/2010	13
OC10 Cables	N/A	10kHz-1GHz RE Cables	OCH	4/1/2010	13
Pre-Amplifier	Miteq	AM-1616-1000	AOM	4/1/2010	13
Spectrum Analyzer	Agilent	E4446A	AAY	1/15/2010	12

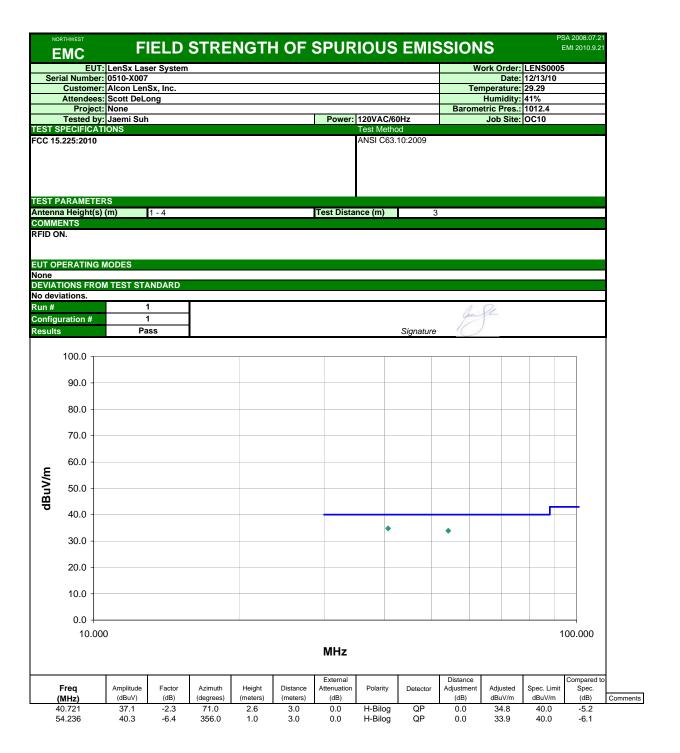
Frequency Range	Peak Data	Quasi-Peak Data	Average Data
(MHz)	(kHz)	(kHz)	(kHz)
0.01 - 0.15	1.0	0.2	0.2
0.15 - 30.0	10.0	9.0	9.0
30.0 - 1000	100.0	120.0	120.0
Above 1000	1000.0	N/A	1000.0

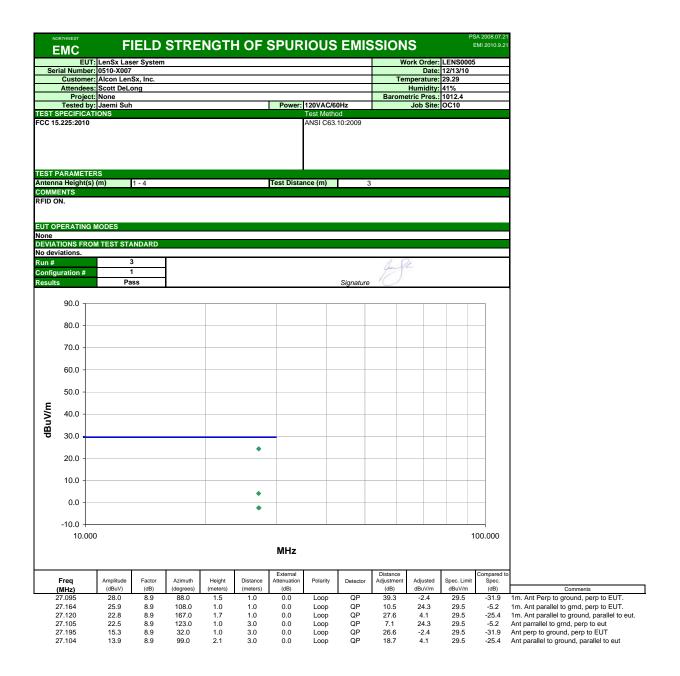
MEASUREMENT UNCERTAINTY

A measurement uncertainty estimation has been performed for each test per our internal quality document WP 342. The estimation is used to compare the measured result with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. The measurement uncertainty estimation is available upon request.

TEST DESCRIPTION

The antennas to be used with the EUT were tested. The EUT was transmitting and receiving while set at the channel available. While scanning, emissions from the EUT were maximized by rotating the EUT, adjusting the measurement antenna height and polarization, and manipulating the EUT antenna in 3 orthogonal planes (per ANSI C63.10:2009).





Distance Adjustment Factor for Spurious Radiated Emissions below 30 MHz

Method: Per 47 CFR 15.31(f)(2), the data was extrapolated based upon a the measured fall-off (at each frequency / polarity).

EUT: LenSx Laser System

S/N: 0510-X007 **Date:** 12/13/10 **Job Number:** LENS0005

Frequency (MHz)	Loop Antenna Polarity	Test Distance	Adjusted Level	Fall-Off from 1 to 3 m	Extrapolation Factor for Specification Limit (dB / decade)	Test Distance of Spec. Limit	Distance Adjustment Factor (dB)
(IVITIZ)	D (O I	(IIIELEIS)	(ubuv/III)	(40)	(ub / decade)	(11101013)	(4.5)
27.095	Perp/Gnd, Perp/EUT	1	36.9	12.7	26.6	30.0	39.3
27.095	Perp/Gnd, Perp/EUT	3	24.2	12.7	20.0	30.0	26.6
27.164	Par/Gnd, Perp/EUT	1	34.8	3.4	7.1	30.0	10.5
27.164	Par/Gnd, Perp/EUT	3	31.4	3.4	7.1	30.0	7.1
27.120	Par/Gnd, Par/EUT	1	31.7	8.9	18.7	30.0	27.6
27.120	Par/Gnd, Par/EUT	3	22.8	0.9	10.7	30.0	18.7

Frequency Stability

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT								
Manufacturer	Model	ID	Last Cal.	Interval				
Cincinnati Sub Zero (CSZ)	ZPHS-32-3.5-SCT/AC	TBE	6/8/2010	24				
Agilent	E4440A	AFA	2/9/2010	12				
Hewlett-Packard	6843A	THB	10/2/2009	16				
	Cincinnati Sub Zero (CSZ) Agilent	Cincinnati Sub Zero (CSZ) ZPHS-32-3.5-SCT/AC Agilent E4440A	Cincinnati Sub Zero (CSZ) ZPHS-32-3.5-SCT/AC TBE Agilent E4440A AFA	Cincinnati Sub Zero (CSZ) ZPHS-32-3.5-SCT/AC TBE 6/8/2010 Agilent E4440A AFA 2/9/2010				

MEASUREMENT UNCERTAINTY

Measurement uncertainty is used to reflect the accuracy of the measured result as compared with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. In the case of transient tests our test equipment has been demonstrated by calibration to provide at least a 95% confidence that it complies with the test specification requirements. The measurement uncertainty for any test is available upon request.

TEST DESCRIPTION

Variation of Supply Voltage

The primary supply voltage was varied from 85% to 115% of nominal. The EUT can only be operated from the public AC mains, so an AC lab supply was used to vary the supply voltage from 115% to 85% of 120 V, 60 Hz.

Variation of Ambient Temperature

Using a temperature chamber, the transmit frequency was recorded at the extremes of the specified temperature range (-20° to +50° C) and at 10°C intervals.

Measurements were made at the single transmit frequency. The antenna is integral to the EUT, so a radiated measurement was made using a spectrum analyzer and a near field probe. The spectrum analyzer is equipped with a precision frequency reference that exceeds the stability requirement of the EUT.

NORTHWEST		F.,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	. Ctability				XMit 2007.06.13
EMC		Frequency	Stability				
EUT:	LenSx Laser System				Work Order:	LENS0005	
Serial Number:	0702723711				Date:	12/13/10	
Customer:	Alcon LenSx, Inc.				Temperature:	23	
Attendees:	Scott DeLong				Humidity:	36%	
Project:	None			Ba	rometric Pres.:	1016.3 mb	
Tested by:			Power: 120VAC/60Hz		Job Site:	OC13	
TEST SPECIFICATION	ONS		Test Method				
FCC 15.225:2010			ANSI C63.4:2003				
COMMENTS							
RFID ON.							
DEVIATIONS FROM	I TEST STANDARD						
No Deviations							
		and the					
Configuration #	1	[-]					
		Signature					
				Value	Lin	nit	Results
Temperature Freque	ncv Stability		,	View Table	0.01% =	100 ppm	Pass
Voltage Frequency S				View Table	0.01% =		Pass

Frequency Stability

Temperature Frequency Stability						
Result: Pass	Value: View Table	Limit:	0.01% = 100 ppm			

Frequency Stability with Variation of Ambient Temperature (Primary Supply = 120 VAC)

Temp (°C)	Assigned Frequency (MHz)	Measured Frequency (MHz)	Tolerance (ppm)	Specification (ppm)
50	13.560000	13.560322	23.75	100
40	13.560000	13.560339	25.00	100
30	13.560000	13.560355	26.18	100
20	13.560000	13.560355	26.18	100
10	13.560000	13.560239	17.63	100
0	13.560000	13.560255	18.81	100
-10	13.560000	13.560272	20.06	100
-20	13.560000	13.560239	17.63	100

	Voltage Frequency Stability			
Result: Pass	Value: View Table	Limit:	0.01% = 100 ppm	

Frequency Stability with Variation of AC Supply Voltage (Ambient Temperature = 20°C)

Voltage (Vac)	Assigned Frequency (MHz)	Measured Frequency (MHz)	Tolerance (ppm)	Specification (ppm)
138.0	13.560000	13.560572	42.18	100
132.0	13.560000	13.560555	40.93	100
126.0	13.560000	13.560532	39.23	100
120.0	13.560000	13.560508	37.46	100
114.0	13.560000	13.560508	37.46	100
108.0	13.560000	13.560528	38.94	100
102.0	13.560000	13.560522	38.50	100

OCCUPIED BANDWIDTH

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT								
Description	Manufacturer	Model	ID	Last Cal.	Interval			
Signal Generator	Agilent	E8257D	TGU	12/20/2008	24			
Spectrum Analyzer	Agilent	E4440A	AFA	2/9/2010	12			

MEASUREMENT UNCERTAINTY

A measurement uncertainty estimation has been performed for each test per our internal quality document WP 342. The estimation is used to compare the measured result with its "true" or theoretically correct value. The expanded measurement uncertainty for radiated emissions measurements is less than +/- 4 dB, and for conducted emissions measurements is less than +/- 2.7 dB. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4; therefore, the test data can be compared directly to the specification limit to determine compliance. The calculations for measurement uncertainty are available upon request.

TEST DESCRIPTION

The occupied bandwidth was measured utilizing the analyzer's peak detector and measuring the carrier's 20 dB occupied bandwidth.

The antenna is integral to the EUT, so a measurement was made with a probe configuration. The resolution bandwidth was >1% of the 20dB bandwidth and the video bandwidth was greater than the resolution bandwidth.

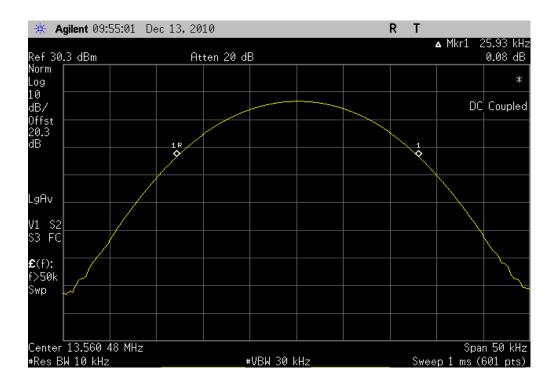
The occupied bandwidth was measured with the EUT configured for continuous modulated operation of the operational band.

NORTHWEST		OCCUPIED	DANDWIE)TU		Х	(Mit 2010.01.14
EMC		OCCOPIED	DAINDVVIL	חות			
EUT:	LenSx Laser System				Work Order:	LENS0005	
Serial Number:						12/17/10	
	Alcon LenSx, Inc.				Temperature:		
	Scott DeLong				Humidity:		
Project:					Barometric Pres.:		
	Jaemi Suh		Power: 120V	AC/60Hz	Job Site:	OC11	
TEST SPECIFICAT	IONS		Test	Method			
FCC 15.225:2010			ANSI	C63.10:2009			
COMMENTS							
None							
DEVIATIONS FROM	M TEST STANDARD						
No Deviations							
Configuration #	1	Jan Ste					
oomigaration "	•	Signature					
				Value	Lii	mit	Results
OCCUPIED BANDV	VIDTH			25.93 kHz	≤ 50	0 kHz	Pass

OCCUPIED BANDWIDTH

 OCCUPIED BANDWIDTH

 Result:
 Pass
 Value:
 25.93 kHz
 Limit:
 ≤ 500 kHz





AC POWERLINE CONDUCTED EMISSIONS

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

MODES OF OPERATION

RFID ON.

POWER SETTINGS INVESTIGATED

120VAC/60Hz

CONFIGURATIONS INVESTIGATED

LENS0005 - 1

SAMPLE CALCULATIONS

Conducted Emissions: Adjusted Level = Measured Level + Transducer Factor + Cable Attenuation Factor + External Attenuator

TEST EQUIPMENT					
Description	Manufacturer	Model	ID	Last Cal.	Interval
LISN	Solar	9252-50-24-BNC	LIB	5/5/2010	12 mo
Attenuator	Pasternack	6N10W-20	AWC	1/27/2010	13 mo
High Pass Filter	TTE	H97-100K-50-720B	HFP	3/8/2010	13 mo
OC06 Cables	OC06 Cables N/A		OCM	3/8/2010	13 mo
Receiver	Rohde & Schwarz	ESCI	ARG	3/15/2010	12 mo

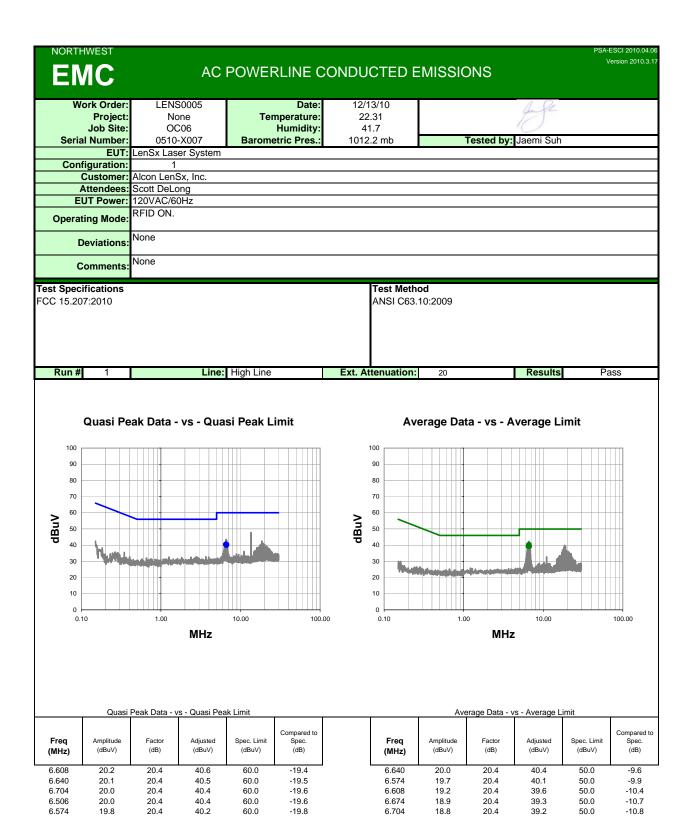
EASUREMENT BANDWIDTHS								
	Frequency Range	Peak Data	Quasi-Peak Data	Average Data				
	(MHz)	(kHz)	(kHz)	(kHz)				
	0.01 - 0.15	1.0	0.2	0.2				
	0.15 - 30.0	10.0	9.0	9.0				
	30.0 - 1000	100.0	120.0	120.0				
	Above 1000	1000.0	N/A	1000.0				
Ň	leasurements were made us	sing the bandwidths and dete	ctors specified. No video filte	er was used.				

MEASUREMENT UNCERTAINTY

A measurement uncertainty estimation has been performed for each test per our internal quality document WP 342. The estimation is used to compare the measured result with its "true" or theoretically correct value. The expanded measurement uncertainty for radiated emissions measurements is less than +/- 4 dB, and for conducted emissions measurements is less than +/- 2.7 dB. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4; therefore, the test data can be compared directly to the specification limit to determine compliance. The calculations for measurement uncertainty are available upon request.

TEST DESCRIPTION

Using the mode of operation and configuration noted within this report, conducted emissions tests were performed. The frequency range investigated (scanned), is also noted in this report. Conducted power line measurements are made, unless otherwise specified, over the frequency range from 150 kHz to 30 MHz to determine the line-to-ground radio-noise voltage that is conducted from the EUT power-input terminals that are directly (or indirectly via separate transformer or power supplies) connected to a public power network. Equipment is tested with power cords that are normally used or that have electrical or shielding characteristics that are the same as those cords normally used. Typically those measurements are made using a LISN (Line Impedance Stabilization Network), the 50ohm measuring port is terminated by a 50ohm EMI meter or a 50ohm resistive load. All 50ohm measuring ports of the LISN are terminated by 50ohm.



6.674

19.5

20.4

39.9

60.0

-20.1

6.506

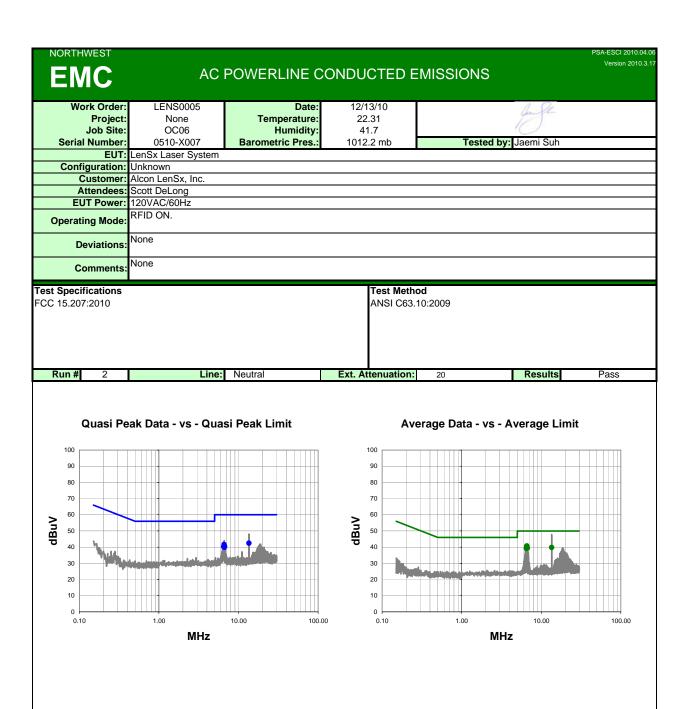
18.8

20.4

39.2

50.0

-10.8



Quasi Peak Data - vs - Quasi Peak Limit Average Data - vs - Average Limit

Freq (MHz)	Amplitude (dBuV)	Factor (dB)	Adjusted (dBuV)	Spec. Limit (dBuV)	Compared to Spec. (dB)	Freq (MHz)	Amplitude (dBuV)	Factor (dB)	Adjusted (dBuV)	Spec. Limit (dBuV)	Compared to Spec. (dB)
13.560	21.5	20.9	42.4	60.0	-17.6	6.606	20.4	20.4	40.8	50.0	-9.2
6.606	21.3	20.4	41.7	60.0	-18.3	6.640	20.1	20.4	40.5	50.0	-9.5
6.640	20.2	20.4	40.6	60.0	-19.4	6.574	20.0	20.4	40.4	50.0	-9.6
6.704	20.1	20.4	40.5	60.0	-19.5	13.560	18.8	20.9	39.7	50.0	-10.3
6.574	20.1	20.4	40.5	60.0	-19.5	6.704	19.0	20.4	39.4	50.0	-10.6
6.508	19.9	20.4	40.3	60.0	-19.7	6.674	19.0	20.4	39.4	50.0	-10.6
6.674	19.5	20.4	39.9	60.0	-20.1	6.508	18.7	20.4	39.1	50.0	-10.9